SN5446A, '47A, '48, SN54LS47, 'LS48, 'LS49, SN7446A, '47A, '48, SN74LS47, 'LS48, 'LS49 BCD-TO-SEVEN-SEGMENT DECODERS/DRIVERS MARCH 1974- REVISED MARCH 1988

SDL	S1	11

Open-Collector Outputs

Lamp-Test Provision

Leading/Trailing Zero

Suppression

Drive Indicators Directly

'46A, '47A, 'LS47 feature

'48, 'LS48 feature

- Internal Pull-Ups Eliminate
 Need for External Resistors
- Lamp-Test Provision
 - Leading/Trailing Zero Suppression
- Open-Collector Outputs

'LS49

feature

Blanking Input

SN5446A, SN5447A, SN54L547, SN5448, SN54LS48 . . . J PACKAGE SN7446A, SN7447A, SN7448 . . . N PACKAGE SN74LS47, SN74LS48 . . . D OR N PACKAGE (TOP VIEW)



SN54LS49 . . . J OR W PACKAGE SN74LS49 . . . D OR N PACKAGE (TOP VIEW)



2 1 20 19 18 🛛 g LT Δ BI/RBO <u>[]</u> 5 17 🛛 a NC 0 G 16 🛛 NC 15 🛛 ь RBI 7 Пв 14 [D С 9 10 11 12 13 GND ധ Ċ ∢

SN54LS47, SN54LS48 ... FK PACKAGE

(TOP VIEW)

SN54LS49 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

PRODUCTION DATA documents contain information current as of publication date. Products conform to spacifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

TEXAS TEXAS INSTRUMENTS

SN5446A, '47A, '48, SN54LS47, 'LS48, 'LS49, SN7446A, '47A, '48, SN74LS47, 'LS48, 'LS49 BCD-TO-SEVEN-SEGMENT DECODERS/DRIVERS

	N5447A Iow open-collector N5448 high 2-kΩ pull-up				TYPICAL	
TYPE	ACTIVE	OUTPUT	SINK	MAX	POWER	PACKAGES
	LEVEL	CONFIGURATION	CURRENT	VOLTAGE	DISSIPATION	
SN5446A	low	open-collector	40 mA	30 V	320 mW	J, W
SN5447A	low	open-collector	40 mA	15 V	320 mW	J, W
SN5448	high	2-kΩ pull-up	6.4 mA	5.5 V	265 mW	J,W
SN54LS47	low	open-collector	12 mA	15 V	35 mW	J, W
SN54LS48	high	2-kΩ pull-up	2 mA	5.5 V	125 mW	J, W
SN54LS49	high	open-collector	4 mA	5.5 V	40 mW	J, W
SN7446A	low	open-collector	40 mA	30 V	320 mW	N ,L
SN7447A	low	open-collector	40 mA	15 V	320 mW	J, N
SN7448	high	2-kΩ pull-up	6.4 mA	5.5 V	265 mW	J, N
SN74LS47	low	open-collector	24 mA	15 V	35 mW	J, N
SN74LS48	high	2-kΩ pull-up	6 mA	5.5 V	125 mW), N
SN74LS49	high	open-collector	8 m A	5.5 V	40 mW	J, N

All Circuit Types Feature Lamp Intensity Modulation Capability

logic symbols[†]



 $^\dagger These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for D, J, N, and W packages.$

TEXAS TEXAS INSTRUMENTS POST OFFICE BOX 655012 • DALLAS, TEXAS 75265

description

The '46A, '47A, and 'LS47 feature active-low outputs designed for driving common-anode LEDs or incandescent indicators directly. The '48, 'LS48, and 'LS49 feature active-high outputs for driving lamp buffers or common-cathode LEDs. All of the circuits except 'LS49 have full ripple-blanking input/output controls and a lamp test input. The 'LS49 - circuit incorporates a direct blanking input. Segment identification and resultant displays are shown below. Display patterns for BCD input counts above 9 are unique symbols to authenticate input conditions.

The '46A, '47A, '48, 'LS47, and 'LS48 circuits incorporate automatic leading and/or trailing-edge zero-blanking control (RBI and RBO). Lamp test (LT) of these types may be performed at any time when the BI/RBO node is at a high level. All types (including the '49 and 'LS49) contain an overriding blanking input (BI), which can be used to control the lamp intensity by pulsing or to inhibit the outputs. Inputs and outputs are entirely compatible for use with TTL logic outputs.

The SN54246/SN74246 and '247 and the SN54LS247/SN74LS247 and 'LS248 compose the Ξ and the Ξ with tails and were designed to offer the designer a choice between two indicator fonts.





SEGMENT IDENTIFICATION

DECIMAL			INP	UTS			BI/RBO†										
FUNCTION	īŦ	RBI	D	С	в	A		а	b	с	d	e	f	g			
0	н	н	L	L,	F	L	н	ON	ON	ON	ON	ON	ON	OFF			
1	н	×	L	L	L	н	н	OFF	ON	ON	OFF	OFF	OFF	OFF			
2	н	X	L	L	н	L	н	ON	ON	OFF	ON	ON	OFF	ON			
3	<u>н</u>	X	L	L	н	н	н	ON	ON	ON	ON_	OFF	OFF	ON			
4	н	×	L	н	 Լ	L	н	OFF	ON	ON	OFF	OFF	ON	ON			
6	н	×	L	н	L	н	н	ON	OFF	ON	ON	OFF	ON	ON			
6	н	×	L	н	н	L	н	OFF	OFF	ON	ON	ON	ON	QN			
7	н	X	L	н	н	н	н	ON	ON	ON	OFF	OFF	OFF	OFF	-		
8	н_	X	н	L	Ļ	L	н	QN	ON	ON	ON	ON	ON	ON			
9	н	x	н	L	Ł	н	н	ON	ON	ON	OFF	OFF	ON	ΟN			
10	н	×	н	L	н	L	Н	OFF	OFF	OFF	ON	ON	OFF	ON			
11	н	X	н	L	н	н	н	OFF	OFF	ON	ON	OFF	OFF	ON			
12	н	X	н	н	L	L	н	OFF	ON	OFF	OFF	OFF	ON	ON			
13	н	x	н	н	L	н	н	ON	OFF	OFF	ON	OFF	ON	ON			
14	н	x	н	н	н	L	н	OFF	OFF	OFF	ON	ON	ON	ON			
15	н	x	н	н	н	н	н	OFF									
BI	×	X	х	х	х	х	L	OFF	2								
RBI	н	L	L	L	F	L	L L	OFF	3								
LT	L	x	x	х	х	х	н	ON	4								

'46A, '47A, 'LS47 FUNCTION TABLE (T1)

 $H \neq high level, L = low level, X = irrelevant$

NOTES: 1. The blanking input (BI) must be open or held at a high logic level when output functions 0 through 15 are desired. The ripple-blanking input (RBI) must be open or high if blanking of a decimal zero is not desired.

2. When a low logic level is applied directly to the blanking input (Bi), all segment outputs are off regardless of the level of any other input.

3. When ripple blanking input (RBI) and inputs A, B, C, and D are at a low level with the lamp test input high, all segment outputs go off and the ripple blanking output (RBD) goes to a low level (response condition).

4. When the blanking input/ripple blanking output (BI/RBO) is open or held high and a low is applied to the lamp-test input, all segment outputs are on,

[†]BI/RBO is wire AND logic serving as blanking input (BI) and/or ripple blanking output (ABO).



SN5446A, '47A, '48, SN54LS47, 'LS48, 'LS49, SN7446A, '47A, '48, SN74LS47, 'LS48, 'LS49 BCD-TO-SEVEN-SEGMENT DECODERS/DRIVERS

	F1							E (T2)	ł						
DECIMAL OR			INPL	JTS	_		BI/RBO [†]			01	JTPU	тѕ			NOTE
FUNCTION	ιī	RBI	D	C	в	A	}	а	Ь	С	d	e	f	g	
n	н	н	L	L	L	L	н	н	н	н	H	н	н	L	
1	н	X	i,	L	L	н	ļн	L	Н	н	L	L	Ł	L	
2	Н	Х	L	L	н	L.	н	н	н	L	н	н	L	н	
3	Н	X	L	L	н	H	н	н	Н	н	н	L	L	н	
4	н	х	L	Н	L	L	н		H	Н	Ľ	E	Н	Н	
5	н	X	L	н	L	н	н	н	L	н	н	i_	н	н	
6	н	X	Ĺ	н	Н	Ł	н	L	L	н	н	н	н	н	
7	н	X	I.	н	Н	н	н	н	н	н	L	L	1	L	1
8	н	X	н	L	L	Ļ	Н	н	н	н	н	н	н	Н	,
9	н	х	н	L	L	н	н	н	Н	Н	L	L	н	н	
10	н	х	н	L	н	L	н	L	L	L	н	н	L	н	
11	н	х	н	L	Н	н	н	LL	L	н	н	L	_L	н	
12	н	х	н	н	L	<u> </u>	н	L	н	L	L	L	н	н	
13	Н	х	н	Н	L	н	н	н	L	L	н	L	Н	н	
14	н	х	н	н	н	L	н	ļ∟	L	ŧ.	н	н	н	н	
15	н	Х	н	н	н	н	н	L.	L.	L	L	L	L	L.	
BI	х	x	х	х	х	х	L	L .	L	L	L	L	 L	L	2
RBI	н	L	L	L	L	L.	L.) L	L	L	L	L	L	L	3
LT	L	X	Х	X	X	Х	н	н	н	н	н	н	н	Н	4

'48, 'LS48

H = high level, L = low level, X = irrelevant

NOTES: 1. The blanking input (B) must be open or held at a high logic level when output functions 0 through 15 are desired. The ripple-blanking input (RB) must be open or high, if blanking of a decimal zero is not desired.

 When a low logic level is applied directly to the blanking input (B1), all segment outputs are low regardless of the level of any other input.

3. When ripple-blanking input (RBi) and inputs A, B, C, and D are at a low level with the lamp-test input high, all segment outputs go low and the ripple-blanking output (RBO) goes to a low level (response condition).

4. When the blanking input/ripple-blanking output (BI/RBO) is open or held high and a low is applied to the lamp-test input, all segment outputs are high.

 $+\overline{BI}/\overline{RBO}$ is wire-AND logic serving as blanking input (\overline{BI}) and/or ripple-blanking output (\overline{RBO}).

				FUN	стю	N TA	BLE	(T3)					
DECIMAL		i	NPUT	S				0	JTPU	τs			NOTE
FUNCTION	D	С	6	Α	BI	a	Ь	c	d	e	f	g	
0	L	L	L.	L	H.	н	н	н	н	н	Н	L	
1	Ł	L	L	н	н	L	н	Н	L	L	L,	Ļ	
2	Ļ	L	н	L	н	Н	н	L	н	н	E	н	
3	L	L	Н	_ <u>H</u> _	_н	н	H	Н_	н	_L	L	H	
4	L	H	L	L	Н	L	Н	н	L	L	н	н	
5	L	н	L	н	н	н	L	н	н	L	н	н	
6	L	н	н	L	Н	L	L	н	н	н	н	н	
7	Ŀ	н	н	н	_н	н	н	н	_L	L	<u> </u>	L	1
8	н	"L	L	L	н	н	н	н	Н	н	н	н	'
9	н	L	L	н	н	н	н	н	L.	L	н	н	
10	н	L	н	L	н	L	L	Ł	Н	н	L	Н	
11	н	L	н	н	н	L	L	H	н	L	L	H	
12	H	н	Ľ	Ľ	н	L	н	L	L	L	н	н	
13	н	н	L	Н	н	н	L	L	н	L	н	H	
14	н	н	н	L	н	L	L	L	н	н	н	H	
15	н	н	н	н	н	L	L	L	L	L	L	L	
BI	X	X	X	X	L	L	Ľ	Ļ	L	L	L	L	2

'LS49

H - high level, L = low level, X = irrelevant

. . . .

NOTES: 1. The blanking input (B) must be open or held at a high logic level when output functions 0 through 15 are desired.

 When a low logic level is applied directly to the blanking input (BI), all segment outputs are low regardless of the level of any other input.



SN5446A, '47A, '48, SN54LS47, 'LS48, SN7446A, '47A, '48, SN74LS47, 'LS48 BCD-TO-SEVEN-SEGMENT DECODERS/DRIVERS



Pin numbers shown are for D, J, N, and W packages.



SN54LS49, SN74LS49 BCD-TO-SEVEN-SEGMENT DECODERS/DRIVERS

logic diagrams (continued)



Pin numbers shown are for D, J, N, and W packages.



i.

SN5446A, '47A, '48, SN7446A, '47A, '48 BCD-TO-SEVEN-SEGMENT DECODERS/DRIVERS

.



h

TEXAS V INSTRUMENTS POST OFFICE BOX 655012 • DALLAS. TEXAS 75265

SN54LS47, 'LS48, 'LS49, SN74LS47, 'LS48, 'LS49 BCD-TO-SEVEN-SEGMENT DECODERS/DRIVERS

schematics of inputs and outputs

•











'LS48



'LS49





SN5446A, SN5447A, SN7446A, SN7447A BCD-TO-SEVEN-SEGMENT DECODERS/DRIVERS

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC} (see Note 1)	
Input voltage	
Current forced into any output in the off state	
Operating free-air temperature range: SN5446A, SN5447A	
SN7446A, SN7447A	0°C to 70°C
Storage temperature range	-65° C to 150° C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

		5	SN5446	A	S	N5447	A	S	N7446	Α	SN7447A			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V _{CC}		4.5	5	5.5	4.5	5	5.5	4.75	5	5.25	4.75	5	5.25	V
Off-state output voltage, VO(off)	a thru g	1		30	_		15			30			15	V
On-state output current, IO(on)	a thru g			40			40			40			40	mA
High-level output current, IOH	BI/RBO	-		200	_		-200			-200			-200	μA
Low-level output current, IOL	BI/RBO			8			8			8			- 8	mΑ
Operating free-air temperature, Tp		-55		125	-55		125	0		70	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER		TEST CONDI	TIONST	MIN	TYP‡	MAX	UNIT
VIH	High-level input voltage				2			V
ViL	Low-level input voltage						0.8	V
۷ік	Input clamp voltage		Vcc = MIN. II =	-12 mA			-1.5	V
V _{OH}	High-level output voltage	BI/RBO	V _{CC} = MIN, VIH V _{IL} = 0.8 V, I _{OH}	-	2.4	3.7	_	۰v
VOL	Low-level output voltage	BI/RBO	V _{CC} = MIN, V _I V _{IL} = 0.8 V, I _{OL}	•		0.27	0.4	v
^I O(off)	Off-state output current	a thru g	V _{CC} = MAX, V _I V _{IL} = 0.8 V, V _O	-			250	μA
VO(on)	On-state output voltage	a thru g	V _{CC} = MIN, V _{IF} V _{IL} = 0.8 V, I _O (-		0.3	0,4	v
II.	Input current at maximum input voltage	Any input except BI/RBO	V _{CC} = MAX, V _I	= 5.5 V			1	mA
ця	High-level input current	Any input except BI/RBO	V _{CC} = MAX, VI	= 2.4 V			40	μА
μL	Low-level input current	Any input except BI/RBO	VCC = MAX, VI	= 0.4 V			-1.6	mA
		BI/RBO]				-4	
los	Short-circuit output current	BI/RBO	V _{CC} = MAX	_	[_4	mΑ
ICC	Supply current		V _{CC} = MAX, See Note 2	SN 54' SN 74'		64 64	85 103	mΑ

[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. [‡]All typical values are at V_{CC} = 5 V, T_A = 25°C. NOTE 2: 1_{CC} is measured with all outputs open and all inputs at 4.6 V.

switching characteristics, VCC = 5 V, TA = 25°C

PARAMETER	TEST CONDITIONS	MIN TYP MAX	UNIT
off Turn-off time from A input		100	ns
an Turn-on time from A input	$C_{L} \approx 15 \text{pF}, R_{L} = 120 \Omega,$	100	
off Turn-off time from RBI input	See Note 3	100	
on Turn-on time from RBI input		100	- ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



SN5448, SN7448 **BCD-TO-SEVEN-SEGMENT DECODERS/DRIVERS**

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)		 									7V
Input voltage		 		-							5.5 V
Operating free-air temperature range	SN5448								-		-55° C to 125° C
											. 0°C to 70°C
Storage temperature range		 	• •		• •		,				–65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

			SN544	В		UNIT		
		MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V _{CC}		4.5	5	5.5	4.75	5	5.25	<u>v</u>
	a thru g			-400			-400	
High-level output current, IOH	BI/RBO			-200			-200	μA
	a thru g	1		6.4			6,4	
Low-level output current, IOL	BI/RBO			8			_8	mA
Operating free-air temperature, T _A		-55		125	0		70	°c

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER		TEST CON	DITIONST	MIN	TYP [‡]	MAX	UNIT
VIH	High-level input voltage				2			V
VIL	Low-level input voltage						0.8	V
VtK	Input clamp voltage		V _{CC} = MIN, I	I = −12 mA			1.5	V
Voн	High-level output voltage	a thru g	V _{CC} = MIN, V	/ _{IH} ≃ 2 V,	2.4	4.2		v
•OH	righterer output vortage	BI/RBO	V1L≏0.8V, 4	он = мах	2.4	3.7		· ·
10	Output current	a thru g	V _{CC} = MIN, V	-	-1.3	-2		mA
			Input conditions					
Vo∟	Low-level output voltage		V _{CC} = MIN, V	/IH = 2 ∨,		0.27	0.4	l v
01			V _{IL} = 0.8 V, I	OL = MAX		•		
1	Input current at maximum input voltage	Any input	V _{CC} = MAX, V	6 E V			1	mA
1	mput content at maximum input voltage	except BI/RBO	CC - MAA, V	r = 5.5 V			1	
1		Any input	- MAX 1		1		40	μA
ін	High-level input current	except BI/RBO	V _{CC} = MAX, V	r - 2.4 V			40	μA
		Any input					-1.6	
կե	Low-level input current	except BI/RBO	V _{CC} = MAX, V	/ _I ≂ 0.4 V			-1.0	mA
		BI/RBO					-4]
los	Short-circuit output current	BI/RBO	V _{CC} = MAX				4	mΑ
		•	VCC = MAX,	SN5448		53	76	mA
ICC	Supply current		See Note 2	SN7448		53	90	ן יייי ן

 † For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. [‡]All typical values are at V_{CC} = 5 V, T_A = 25°C. NOTE 2: I_{CC} is measured with all outputs open and all inputs at 4.5 V.

switching characteristics, V_{CC} = 5 V, T_A = 25 °C

PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
^t PHL Propagation delay time, high-to-low-level output from A input			100	ns
tpLH Propagation delay time, low-to-high-level output from A input	$C_{L} = 15 \text{pF}, R_{L} = 1 \text{k}\Omega$		100	115
tpht Propagation delay time, high-to-low-level output from HBI input	See Note 3		100	ńs
¹ PLH Propagation delay time, law-to-high-level output from RBI input			100	

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



SN54LS47, SN74LS47 **BCD-TO-SEVEN-SEGMENT DECODERS/DRIVERS**

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

	*		~		•			 •											
Supply voltage, V _{CC} (see Note 1) .												. .					7 V
Input voltage											-		-				-		7 V
Peak output current (t																			
Current forced into an	iy output i	n the	e off sta	te .						-			•						1 mA
Operating free-air tem	perature ra	inge:	SN541	LS47			-					-			-	-55	°C	to 1	25°C
			SN74	LS47								-					0°0	C to	70°C
Storage temperature ra	ange											-			-	-65	°C	to 1	50°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

		S	N54LS4	17	SN74LS47						
		MIN	NOM	MAX	MIN	NOM	МАХ	UNIT			
Supply voltage, VCC	······································	4.5	5	5.5	4.75	5	5.25	V			
Off-state output voltage, VO(off)	a thru g			15			15	V			
On-state output current, IO(on)	a thiugi			12			24	mA			
High-level output current, IOH	BI/RBO	1		-50	<u> </u>		-50	μA			
Low-level output current, IOL	BI/RBO			1.6	1		3.2	mA			
Operating free-air temperature, TA		-55		125	0		70	°C			

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

				n.n.o.ust	S	N54LS4	17	S	N74LS	47	
	PARAMETER	1	TEST CON	IDITIONS [†]	MIN	TYP‡	MAX	MIN	τyρ‡	MAX	UNIT
∨ін	High-level input voltage		· · · · · · · · · · · · · · · · · · ·		2			2			v
VIL	Low-level input voitage						0.7	1		0.8	V
VIK	Input clamp voltage		V _{CC} = MIN,	lj =18 mA			-1.5			-1.5	V
VOH	High-level output voltage	BI/REO	V _{CC} = MIN, V _{IL} = V _{IL} max,	V _{IH} = 2 V, 1 _{OH} = -50 μA	2.4	4.2		2.4	4.2		v
VOL	Low-level output voltage	BI/REO	V _{CC} = MIN, V _{IH} = 2 V,	I _{OL} = 1.6 mA		0.25	0.4		0.25	0.4	v
			V _{IL} = V _{IL} max	t _{OL} = 3.2 mA					0.35	0.5	
^I O{off}	Off-state output current	a thru g	V _{CC} ≕ MAX, V _{IL} ≕ V _{IL} max,	V _{IH} = 2 V, V _{O(off)} = 15 V			250			250	μA
VO(an)	On-state output voltage	a thru g	V _{CC} = MIN, V _{IH} = 2 V,	1 _{0(on)} = 12 mA		0.25	0.4		0.25	0.4	v
O(dii)			VIL = VIL max	10(on) = 24 mA					0.35	0.5	
łį –	Input current at maximur	n input voltage	V _{CC} = MAX,	V1 = 7 V			0.1			0.1	mA
ін	High-level input current		V _{CC} = MAX,	V ₁ = 2.7 V			20			20	μA
μL	Low-level input current	Any input except BI/RBO	V _{CC} = MAX,	V ₁ = 0.4 V			-0.4			-0.4	mA
		BI/RBO					-1.2			-1.2]
IOS	Short-circuit output current	BI/RBO	V _{CC} = MAX		-0.3		-2	-0.3		-2	mA
1cc	Supply current	-	V _{CC} = MAX,	See Note 2		7	13		7	13	mA

[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. [‡]All typical values are at $V_{CC} = 5 V$, $T_A = 25^{\circ}C$. NOTE 2: I_{CC} is measured with all outputs open and all inputs at 4.5 V.

switching characteristics, $V_{CC} = 5 V$, $T_A = 25 °C$

	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
toff	Turn-off time from A input				100	
ton	Turn-on time from A input	$C_{L} = 15 \rho F, R_{L} = 665 \Omega,$			100	ns
[†] off	Turn-off time from RBI input, outputs (a-f) only	See Note 3			100	
ton	Turn-on time from RBI input, outputs (a-f) only				100	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



SN54LS48, SN74LS48 BCD-TO-SEVEN-SEGMENT DECODERS/DRIVERS

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1)											
Input voltage											
Operating free-air temperature range:	SN54LS48			 	• .					-55°	C to 125°C
	SN74LS48		 	 	• •					. C	°C to 70°C
Storage temperature range			 •	 -	• •	· .	•		•	-65°	C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

	S	N54LS4	18	S	N74LS4	8	
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT
	4.5	5	5.5	4.75	5	5.25	V
a thru g	ļ		- 100			-100	
BI/RBO			-50			-50	μA
athrug			2			6	mA
BI/RBO		-	1.6			3.2	mA
	-55		125	0		70	°C
	BI/RBO a thru g	MIN 4.5 BI/RBO a thru g BI/RBO	MIN NOM 4.5 5 a thru g BI/RBO a thru g BI/RBO	4.5 5 5.5 a thru g -100 B1/RBO -50 a thru g 2 B1/RBO 1.6	MIN NOM MAX MIN 4.5 5 5.5 4.75 a thru g -100 BI/RBO -50 a thru g 2 BI/RBO 1.6	MIN NOM MAX MIN NOM 4.5 5 5.5 4.75 5 a thru g -100	MIN NOM MAX MIN NOM MAX 4.5 5 5.5 4.75 5 5.25 a thru g -100 -100 -100 BI/RBO -50 -50 -50 a thru g 2 6 6 BI/RBO 1.6 3.2 3.2

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	· · ·	TECT CON		S	N54LS4	18	S	N74LS4	18	UNIT
			1EST CON		MIN	түр‡	MAX	MIN	TYP [‡]	MAX	UNIT
⊻н	High-level input voltage				2			2			V
VIL	Low-level input voltage						0.7			0.8	V
Vіқ	Input clamp voltage		VCC = MIN,	lj = -18 mA	[-1.5			- 1.5	V
∨он	High-level output voltage	a thru g and BI/RBO	V _{CC} = MIN, V _{IL} = V _{IL} max,	••••	2.4	4.2		2.4	4.2		v
1 ₀	Output current	a thru g	V _{CC} = MIN, Input conditions	V _D = 0.85 V, as for V _{OH}	-1.3	-2		-1.3	-2		mA
		a thru q	V _{CC} = MIN, V _{IH} = 2 V,	1 _{0L} = 2 mA		0.25	0.4		0.25	0.4	~
Vol	Low-level output voltage	u tinu g	V _{IL} ≂ V _{IL} max	I _{OL} = 6 mA					0.35	0.5	
-OL	and the support of the	BI/R80	V _{CC} ≈ MIN, VIH = 2 V.	10L = 1.6 mA		0.25	0.4		0.25	0.4	
		00000	VIH ZV. VIL = VIL max	I _{OL} = 3.2 mA		_			0.35	0.5	
ц	Input current at maximum input voltage	Any input except BI/BRO	V _{CC} = MAX,	V ₁ = 7 V			Q.1			0.1	mA
ЦΗ	High-level input current	Any input except BI/RBO	V _{CC} = MAX,	V ₁ = 2.7 V			20			20	μA
ι _ι	Low-level input current	Any input except BI/RBO	V _{CC} = MAX,	VI = 0.4 V			-0.4			-0.4	mА
		BI/RBO	[-1.2			-1.2]
los	Short-circuit output current	BI/RBO	V _{CC} = MAX		-0.3		-2	-0.3		-2	mA
lcc	Supply current	• • • • • • • • • • • • • • • • • • • •	V _{CC} = MAX,	See Note 2		25	38	1	25	38	mA

[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

.

TAll typical values are at $V_{CC} = 5$ V, T_A 25°C. NOTE 2: I_{CC} is measured with all outputs open and all inputs at 4.5 V.

switching characteristics, $V_{CC} = 5 V$, $T_A = 25 °C$

PARAMETER	TEST CONDITIONS	MIN	ΤΥΡ_	MAX	UNIT
¹ PHL Propagation delay time, high-to-low-level output from A input	$C_{L} = 15 \text{ pF}, \text{H}_{L} = 4 \text{ k}\Omega,$			100	
tpLH Propagation delay time, low-to-high-level output from A input	time, low-to-high-level output from A input See Note 3			100	ns
tpHL Propagation delay time, high-to-low-level output (a-f only) from RBI input	$C_{L} = 15 pF, R_{L} = 6 k\Omega,$	_		100	
^t PLH Propagation delay time, low-to-high-level output (a-f only) from RBI input	See Note 3			100	113

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



PUST OFFICE BOX 655012 . DALLAS, TEXAS 75265

SN54LS49, SN74LS49 BCD-TO-SEVEN-SEGMENT-DECODERS/DRIVERS

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

· ·	-			•										· ·				
Supply voltage, VCC (see Note 1)			-	•		•		•										7 V
Input voltage																		7 V
Current forced into any output in the	e off state																	1 mA
Operating free-air temperature range:	SN54LS49)								-		-	-		-5	،°5ذ	C to	125°C
	SN74LS49)														0	°C t	o 70° C
Storage temperature range					-										$-\epsilon$	5°	C to	150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

	S	N54LS4	19	S	[
	MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V _{CC}	4.5	5	5.5	4.75	5	5.25	$\overline{\nabla}$
High-level output voltage, VOH			5.5			6.5	v
Low-level output current, IOL			4			8	mA
Operating free-air temperature, TA	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS [†]		SN54LS49			SN74LS49			
		TEST CONDITIONS'		MIN	TYP‡	MAX	MIN	TYP‡	MAX	
v_{tH}	High-level input voltage			2	2		2			
VIL	Low-level input voltage			1		0.7			0.8	V
VIK	Input clamp voitage	V _{CC} = MIN,	l = −18 mA	1		-1.5			-1.5	V
юн	High-level output current	V _{CC} = MIN, V _{LL} = V _{LL} max,	V _{IH} = 2 V, V _{OH} = 5.5 V			250			250	Αμ
Vol	Low-level output voltage	$V_{CC} = MIN,$ $V_{IH} = 2 V,$	1 _{0L} = 4 mA	-	0.25	0.4		0.25	0.4	
		VIL = VIL max	IOL = 8 mA					0.35	0.5	
4	Input current at maximum input voltage	V _{CC} = MAX,	V1 = 7 V			0.1			0.1	mA
Чн	High-level input current	V _{CC} = MAX,	V1 = 2.7 V			20			20	μA
ή _μ	Low-level input current	V _{CC} = MAX,	V1 = 0.4 V	1		-0.4			-0.4	mA
lcc	Supply current	VCC = MAX,	See Note 2	+	8	15	-	- 8	15	mA

[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. [‡]All typical values are at V_{CC} \approx 5 V, T_A \neq 25°C. NOTE 2: 1_{CC} is measured with all outputs open and all inputs at 4.5 V.

switching characteristics, $V_{CC} = 5 V$, $T_A = 25 °C$

PARAMETER	TEST CONDITIONS	MIN	түр	MAX	UNIT
tPHL Propagation delay time, high-to-low-level output from A input	$C_{L} = 15 pF, R_{L} = 4 k\Omega,$			100	
tPLH_Propagation delay time, low-to-high-level output from A input	See Note 3			100	ns
tPHL Propagation delay time, high-to-low-level output (a-f only) from RBI input	$C_{L} = 15 \text{ pF}, R_{L} = 6 \text{ k}\Omega,$	-		100	
^t PLH Propagation delay time, low-to-high-level output (a-f only) from RBI input	See Note 3			100	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1,

IMPORTANT NOTICE

Texas Instruments (TI) reserves the right to make changes to its products or to discontinue any semiconductor product or service without notice, and advises its customers to obtain the latest version of relevant information to verify, before placing orders, that the information being relied on is current.

TI warrants performance of its semiconductor products and related software to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

Certain applications using semiconductor products may involve potential risks of death, personal injury, or severe property or environmental damage ("Critical Applications").

TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, INTENDED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT APPLICATIONS, DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS.

Inclusion of TI products in such applications is understood to be fully at the risk of the customer. Use of TI products in such applications requires the written approval of an appropriate TI officer. Questions concerning potential risk applications should be directed to TI through a local SC sales office.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards should be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance, customer product design, software performance, or infringement of patents or services described herein. Nor does TI warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used.

Copyright © 1996, Texas Instruments Incorporated